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CONFIRMATION NO. 3715

SERIAL NUMBER	FILING OR 371(c) DATE	CLASS	GROUP ART UNIT	ATTORNEY DOCKET NO.
10/731,511	12/09/2003	438	2812	BUR920010031US2
APPLICANTS Wagdi W. Abadeer, Jericho, VT; Erle Adler, Jericho, VT; Jeffrey S. Brown, Middlesex, VT; Robert J. Gauthier JR., Hinesburg, VT; Jonathan M. McKenna, Ann Arbor, MI; Jed H. Rankin, South Burlington, VT; Edward W. Sengle, Hinesburg, VT; William R. Tonti, Essex Junction, VT;				
** CONTINUING DATA ***** <i>Yes</i> This application is a DIV of 10/449,426 05/30/2003 PAT 6,770,907 which is a DIV of 09/989,850 11/20/2001 PAT 6,624,031				
** FOREIGN APPLICATIONS ***** <i>No</i>				
IF REQUIRED, FOREIGN FILING LICENSE GRANTED ** 03/10/2004				
Foreign Priority claimed <input type="checkbox"/> yes <input checked="" type="checkbox"/> no 35 USC 119 (a-d) conditions met <input type="checkbox"/> yes <input checked="" type="checkbox"/> no <input type="checkbox"/> Met after Allowance Verified and Acknowledged <i>Andrew Stevenson</i> Examiner's Signature Initials		STATE OR COUNTRY VT	SHEETS DRAWING 22	TOTAL CLAIMS 19
INDEPENDENT CLAIMS 5				
ADDRESS 24241				
TITLE Test structure and methodology for semiconductor stress-induced defects and antifuse based on same test structure				
FILING FEE RECEIVED 942	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:		<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees (Filing) <input type="checkbox"/> 1.17 Fees (Processing Ext. of time) <input type="checkbox"/> 1.18 Fees (Issue) <input type="checkbox"/> Other _____ <input type="checkbox"/> Credit	